

<b>Notice of References Cited</b>	Application/Control No. 10/799,462	Applicant(s)/Patent Under Reexamination DEPABLO ET AL.	
	Examiner David Lukton	Art Unit 1654	Page 1 of 1

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*	E	US-6,723,497	04-2004	Wolkers et al.	435/2
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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